

**Search Notes**

Application/Control No.

10/614,930

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under  
Reexamination

DOBNER ET AL.

Art Unit

2614

**SEARCHED**

Class	Subclass	Date	Examiner
379	114 121	4/26/2006	QN
455	461	4/26/2006	QN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
searched east, USPGPub, USPAT	4/26/2006	QN
Inventor searched through PALM database	4/26/2006	QN